

<b>Search Notes</b>  <b>*1055566</b>  <b>3*</b>	<b>Application/Control No.</b>  10555663	<b>Applicant(s)/Patent Under Reexamination</b>  FUJIKAWA ET AL.
	<b>Examiner</b>  BENJAMIN SCHIFFMAN	<b>Art Unit</b>  1742

### SEARCHED

Class	Subclass	Date	Examiner

### SEARCH NOTES

Search Notes	Date	Examiner
264/ text limited	6/3/2009	BAS
inventor name search	6/3/2009	BAS
google scholar search	6/3/2009	BAS
see EAST search notes	6/3/2009	BAS
google scholar search	7/12/2010	BAS
google scholar search	12/13/2010	BAS

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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Examiner,Art Unit 1742